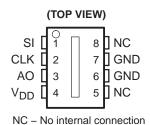
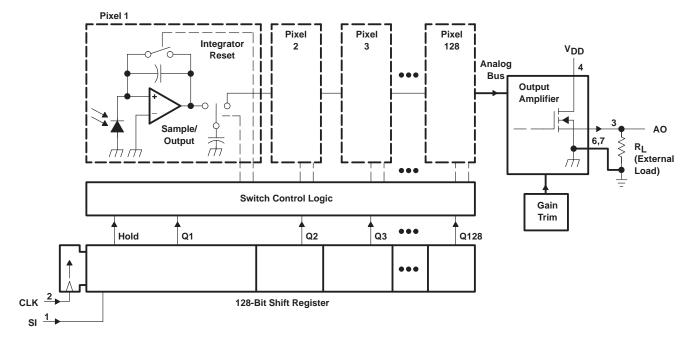
- 128 × 1 Sensor-Element Organization
- 400 Dots-Per-Inch (DPI) Sensor Pitch
- High Linearity and Uniformity for 256 Gray-Scale (8-Bit) Applications
- Output Referenced to Ground
- Low Image Lag . . . 0.5% Typ
- Operation to 2 MHz
- Single 5-V Supply



### description

The TSL1401 linear sensor array consists of a  $128 \times 1$  array of photodiodes, associated charge amplifier circuitry, and a pixel data-hold function that provides simultaneous-integration start and stop times for all pixels. The pixels measure 63.5  $\mu$ m (H) by 55  $\mu$ m (W) with 63.5- $\mu$ m center-to-center spacing and 8.5- $\mu$ m spacing between pixels. Operation is simplified by internal control logic that requires only a serial-input (SI) signal and a clock.

### functional block diagram





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



### **Terminal Functions**

TERMI	NAL	DESCRIPTION				
NAME	NO.					
AO	3	Analog output				
CLK	2	Clock. The clock controls charge transfer, pixel output, and reset.				
GND	6, 7	Ground (substrate). All voltages are referenced to the substrate.				
NC	5, 8	No internal connection				
SI	1	Serial input. SI defines the start of the data-out sequence.				
$V_{DD}$	4	Supply voltage. Supply voltage for both analog and digital circuits.				

### detailed description

The sensor consists of 128 photodiodes arranged in a linear array. Light energy impinging on a photodiode generates photocurrent, which is integrated by the active integration circuitry associated with that pixel.

During the integration period, a sampling capacitor connects to the output of the integrator through an analog switch. The amount of charge accumulated at each pixel is directly proportional to the light intensity and the integration time.

The output and reset of the integrators is controlled by a 128-bit shift register and reset logic. An output cycle is initiated by clocking in a logic 1 on SI. This causes all 128 sampling capacitors to be disconnected from their respective integrators and starts an integrator reset period. As the SI pulse is clocked through the shift register, the charge stored on the sampling capacitors is sequentially connected to a charge-coupled output amplifier that generates a voltage on analog output AO. The integrator reset period ends 18 clock cycles after the SI pulse is clocked in. Then the next integration period begins.

AO is driven by a source follower that requires an external pulldown resistor. When the output is not in the output phase, it is in a high-impedance state. The output is nominally 0 V for no light input and 2 V for a nominal full-scale output.

The TSL1401 is intended for use in a wide variety of applications, including: image scanning, mark and code reading, optical character recognition (OCR) and contact imaging, edge detection and positioning, and optical linear and rotary encoding.



## absolute maximum ratings<sup>†</sup>

Supply voltage, V <sub>DD</sub>	
Digital input current range, I <sub>1</sub>	
Operating free-air temperature range, T <sub>A</sub>	0°C to 70°C
Storage temperature range, T <sub>Stq</sub>	–25°C to 85°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## recommended operating conditions (see Figure 1 and Figure 2)

	MIN	NOM	MAX	UNIT
Supply voltage, V <sub>DD</sub>	4.5	5	5.5	V
Input voltage, V <sub>I</sub>	0		$V_{DD}$	V
High-level input voltage, V <sub>IH</sub>	$V_{DD} \times 0.7$		$V_{DD}$	V
Low-level input voltage, V <sub>IL</sub>	0		$V_{DD} \times 0.3$	V
Wavelength of light source, $\lambda$	400		700	nm
Clock frequency, f <sub>clock</sub>	5		2000	kHz
Sensor integration time, t <sub>int</sub>	0.0645		100	ms
Setup time, serial input, t <sub>SU(SI)</sub>	0			ns
Hold time, serial input, t <sub>h(SI)</sub> (see Note 1)	20			ns
Operating free-air temperature, T <sub>A</sub>	0		70	°C

NOTE 1: SI must go low before the rising edge of the next clock pulse.

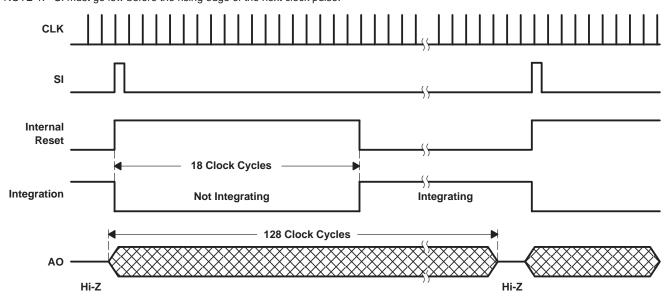


Figure 1. Timing Waveforms

### $128 \times 1$ Linear Sensor array with Hold

SOES029 - JUNE 1996

# electrical characteristics at f<sub>clock</sub> = 200 kHz, V<sub>DD</sub> = 5 V, T<sub>A</sub> = 25°C, $\lambda_p$ = 565 nm, t<sub>int</sub> = 5 ms, R<sub>L</sub> = 330 $\Omega$ , E<sub>e</sub> = 14 $\mu$ W/cm<sup>2</sup> (unless otherwise noted) (see Note 2)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
	Analog output voltage (white, average over 128 pixels)		1.8	2	2.2	V	
	Analog output voltage (dark, average over 128 pixels)	$E_e = 0$	0	0.1	0.2	V	
PRNU	Pixel response nonuniformity	See Note 3		±4%	± 7.5%		
	Nonlinearity of analog output voltage	See Note 4		±0.4%		FS	
	Output noise voltage	See Note 5		1		mVrms	
	Saturation exposure		136	175		nJ/cm <sup>2</sup>	
	Analog output saturation voltage		3	3.5		V	
		All pixels, $E_e = 0$ See Note 6		0.08	0.120		
DSNU	Dark signal nonuniformity	All except pixel 1, E <sub>e</sub> = 0 See Note 6		0.017	0.035	V	
IL	Image lag	See Note 7		0.5%			
I <sub>DD</sub>	Supply current			2.5	4	mA	
Ι <sub>ΙΗ</sub>	High-level input current	$V_I = V_{DD}$			1	μΑ	
IIL	Low-level input current	V <sub>I</sub> = 0			1	μА	
Ci	Input capacitance			5	_	pF	

NOTES: 2. Clock duty cycle is assumed to be 50%.

- 3. PRNU is the maximum difference between the voltage from any single pixel and the average output voltage from all pixels of the device under test when the array is uniformly illuminated.
- 4. Nonlinearity is defined as the maximum deviation from a best-fit straight line over the dark-to-white irradiance levels, as a percent of analog output voltage (white).
- 5. RMS noise is the standard deviation of a single-pixel output under constant illumination as observed over a 5-second period.
- 6. DNSU is the difference between the maximum and minimum of dark-current voltage.
- 7. Image lag is a residual signal left in a pixel from a previous exposure. It is defined as a percent of white-level signal remaining after a pixel is exposed to a white condition followed by a dark condition:

$$IL = \frac{V_{AO}^{-V}AO(dark)}{V_{AO(white)} - V_{AO(dark)}} \times 100$$



## operating characteristics over recommended ranges of supply voltage and operating free-air temperature (see Figure 2)

	PARAMETER	TEST CO	MIN	TYP	MAX	UNIT	
tw(H)	Clock pulse duration (high)			50			ns
t <sub>w(L)</sub>	Clock pulse duration (low)			50			ns
t <sub>S</sub>	Analog output settling time to ±1%	$R_L = 330 \Omega$ ,	C <sub>L</sub> = 50 pF		350		ns

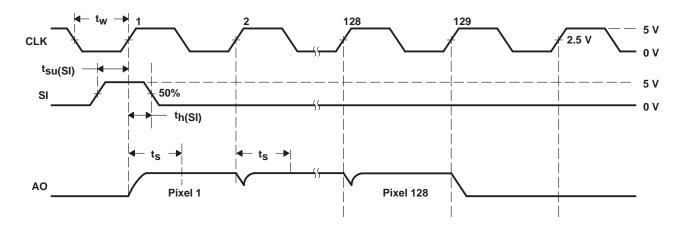


Figure 2. Operational Waveforms

### **TYPICAL CHARACTERISTICS**

### PHOTODIODE SPECTRAL RESPONSIVITY

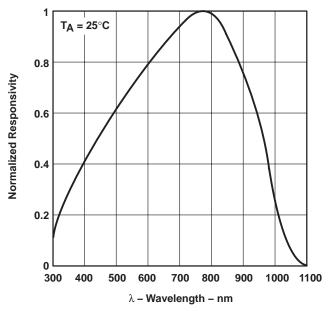
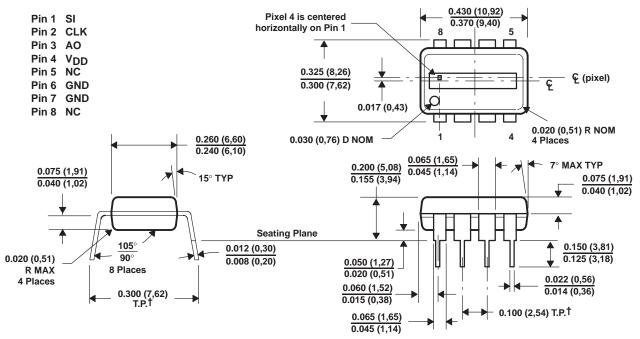


Figure 3



### **APPLICATIONS INFORMATION**

This dual-in-line package consists of a circuit mounted on a lead frame and encapsulated with an electrically nonconductive clear plastic compound.



† True position when unit is installed

NOTES: A. All linear dimensions are in inches and parenthetically in millimeters.

B. This drawing is subject ot change without notice.

Figure 4. Packaging Configuration





### PACKAGE OPTION ADDENDUM

2-Mar-2009

### PACKAGING INFORMATION

Orderable I	Device Status (1)	Package Type	Package Drawing	Pins Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TSL140	OBSOLETE	XCEPT	COB	14	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND**: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

**Applications Products Amplifiers** amplifier.ti.com Audio www.ti.com/audio Data Converters Automotive www.ti.com/automotive dataconverter.ti.com DLP® Products Broadband www.dlp.com www.ti.com/broadband DSP Digital Control dsp.ti.com www.ti.com/digitalcontrol Clocks and Timers www.ti.com/clocks Medical www.ti.com/medical Military Interface www.ti.com/military interface.ti.com Optical Networking Logic logic.ti.com www.ti.com/opticalnetwork Power Mgmt power.ti.com Security www.ti.com/security Telephony Microcontrollers microcontroller.ti.com www.ti.com/telephony Video & Imaging www.ti-rfid.com www.ti.com/video RF/IF and ZigBee® Solutions www.ti.com/lprf Wireless www.ti.com/wireless

> Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2009, Texas Instruments Incorporated